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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
09/532,915	03/22/2000	Masahiko Hayakawa	SEL 170	8547
75	90 02/04/2003			
Mark J Murphy Cook alex McFarron Manzo Cummings & Mehler Ltd. 200 West Adams Street Suite 2850 Chicago, IL 60606			EXAMINER SEFER, AHMED N	
			2826	

Please find below and/or attached an Office communication concerning this application or proceeding.

		lm				
	Application No.	Applicant(s)				
Office Action Summany	09/532,915	HAYAKAWA ET AL.				
Office Action Summary	Examiner	Art Unit				
,	A. Sefer	2826				
The MAILING DATE of this communication appears on the cover sheet with the correspondence address Period for Reply						
A SHORTENED STATUTORY PERIOD FOR REPL THE MAILING DATE OF THIS COMMUNICATION.  - Extensions of time may be available under the provisions of 37 CFR 1. after SIX (6) MONTHS from the mailing date of this communication.  - If the period for reply specified above is less than thirty (30) days, a replif NO period for reply is specified above, the maximum statutory period.  - Failure to reply within the set or extended period for reply will, by statured.  - Any reply received by the Office later than three months after the mailing earned patent term adjustment. See 37 CFR 1.704(b).	.136(a). In no event, however, may a rooty within the statutory minimum of thind I will apply and will expire SIX (6) MON the cause the application to become AE	eply be timely filed  y (30) days will be considered timely. THS from the mailing date of this communication. ANDONED (35 U.S.C. § 133).				
1) Responsive to communication(s) filed on 13	November 2002					
2a)⊠ This action is <b>FINAL</b> . 2b)□ T	his action is non-final.					
<ol> <li>Since this application is in condition for allow closed in accordance with the practice unde Disposition of Claims</li> </ol>						
4)⊠ Claim(s) <u>1-11 and 14-57</u> is/are pending in the application.						
4a) Of the above claim(s) is/are withdrawn from consideration.						
5) Claim(s) is/are allowed.						
6)⊠ Claim(s) <u>1-11 and 14-57</u> is/are rejected.						
7) Claim(s) is/are objected to.						
8) Claim(s) are subject to restriction and/or election requirement.						
Application Papers						
9) The specification is objected to by the Examiner.						
10) The drawing(s) filed on is/are: a) accepted or b) objected to by the Examiner.						
Applicant may not request that any objection to the drawing(s) be held in abeyance. See 37 CFR 1.85(a).						
11) The proposed drawing correction filed on is: a) approved b) disapproved by the Examiner.  If approved, corrected drawings are required in reply to this Office action.						
12) The oath or declaration is objected to by the Examiner.						
Priority under 35 U.S.C. §§ 119 and 120	Adminor.					
	an priority under 35 U.S.C.	8 119(a)-(d) or (f)				
13) Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f). a) All b) Some * c) None of:						
1. Certified copies of the priority documents have been received.						
2. Certified copies of the priority documents have been received in Application No						
3. Copies of the certified copies of the priority documents have been received in this National Stage						
application from the International B  * See the attached detailed Office action for a lis	Bureau (PCT Rule 17.2(a)).					
14) Acknowledgment is made of a claim for domestic priority under 35 U.S.C. § 119(e) (to a provisional application).						
<ul> <li>a)  The translation of the foreign language p</li> <li>15)  Acknowledgment is made of a claim for domes</li> </ul>						
Attachment(s)						
<ol> <li>Notice of References Cited (PTO-892)</li> <li>Notice of Draftsperson's Patent Drawing Review (PTO-948)</li> <li>Information Disclosure Statement(s) (PTO-1449) Paper No(s)</li> </ol>	5) Notice of	Summary (PTO-413) Paper No(s) Informal Patent Application (PTO-152)				

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#### **DETAILED ACTION**

# Claim Rejections - 35 USC § 102

1. The following is a quotation of the appropriate paragraphs of 35 U.S.C. 102 that form the basis for the rejections under this section made in this Office action:

A person shall be entitled to a patent unless -

- (b) the invention was patented or described in a printed publication in this or a foreign country or in public use or on sale in this country, more than one year prior to the date of application for patent in the United States.
- 2. Claims 1-3, 5, 6 and 10 are rejected under 35 U.S.C. 102(b) as being anticipated by lyer et al. (WO 99/10918).

Iyer et al disclose (see figs. 1-3 and page 8) a semiconductor device having a thin film transistor, the semiconductor device comprising a silicon oxide nitride film 106 formed over a substrate 100 or an insulating film formed over a substrate and having at least a silicon oxide nitride film 106 and an insulating layer containing silicon an oxygen 102 (as in claim 3) or made of silicon oxide (as in claim 10); and an active region 120 (see page 8, lines 10-20) formed over the silicon oxide nitride film, wherein the silicon oxide nitride film falls within the claimed range of 0.3 to 1.6 in a ratio of the concentration of nitrogen to the concentration of silicon; wherein the silicon oxide nitride film falls within the claimed range of 0.1 to 1.7 in a ratio of the concentration of oxygen to the concentration of silicon (as in claim 2).

As to claims 5 and 6, lyer et al disclose a silicon oxide nitride film 306 in contact with a surface of a substrate.

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# Claim Rejections - 35 USC § 103

- 3. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:
  - (a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.
- 4. Claims 4 and 11 are rejected under 35 U.S.C. 103(a) as being unpatentable over lyer et al.

lyer et al disclose (see figs. 1-3 and page 8) an insulating film formed over a substrate and having at least a silicon oxide nitride film 106 and an insulating layer containing silicon and oxygen 102 or made of silicon oxide (as in claim 11); and a semiconductor film 120 formed over the silicon oxide nitride film, wherein the silicon oxide nitride film falls within the claimed range of 0.1 to 1.7 in a ratio of the concentration of oxygen to the concentration of silicon.

lyer et al do not specifically disclose a non-single crystal semiconductor film formed over an insulating layer. However, it would have been obvious to one skilled in the art at the time the invention was made to employ an art-recognized material non-single crystal semiconductor film, since that would provide a high switching speed and a high mobility.

5. Claims 7 and 8 are rejected under 35 U.S.C. 103(a) as being unpatentable over lyer et al

lyer et al disclose all the claimed subject matter, but do not teach a semiconductor film in contact with a surface of a silicon oxide layer.

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However, it would have been obvious to one skilled in the art at the time the invention was made to modify the invention of lyer et al such that a semiconductor film is in contact with a surface of a silicon oxide layer, since that would improve the characteristic and reliability of a gate insulating film.

6. Claim 9 is rejected under 35 U.S.C. 103(a) as being unpatentable over lyer et al.

lyer et al disclose all the claimed subject matter including a silicon oxide nitride
film that falls within the claimed range of 0.1 to 0.8 in a ratio of the concentration of
nitrogen to the concentration of silicon except for another layer of silicon oxide nitride.

It would have been obvious to one skilled in the art at the time the invention was made to employ another silicon oxide layer, since it has been held that mere duplication of the essential working parts of a device involves only routine skill in the art. St. Regis Paper Co. V. Bemis., 193 USPQ 8.

7. Claims 18 and 19 are rejected under 35 U.S.C. 103(a) as being unpatentable over lyer et al. in view of Van der Groen et al. US Patent No. 6,093,577.

lyer et al disclose (see figs. 1-3, pages 8 and 11) an insulating underlying film formed over a substrate and having at least a silicon oxide nitride film 106 and an insulating layer containing silicon and oxygen 102; and a semiconductor film 120 formed over the insulating underlying film, wherein the silicon oxide nitride film falls within the claimed range of 0.3 to 1.6 in a ratio of the concentration of nitrogen to the concentration of silicon; wherein the silicon oxide nitride film falls within the claimed range of 0.1 to 1.7 in a ratio of the concentration of oxygen to the concentration of silicon (as in claim 19); wherein the silicon oxide nitride film has a thickness that falls

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within the claimed range of 50-200 nm, and wherein the insulating layer containing silicon and oxygen has a thickness that falls within the claimed range of 10-300 nm.

Van der Groen et al disclose (see figs. 1-10 and col. 5, lines 60-65) a semiconductor film comprising a channel forming region provided over an insulating underlying film 13; a gate insulating film provided channel forming region; and a gate electrode provided adjacent to the channel forming region and over the gate insulating film.

Therefore, it would have been obvious to one skilled in the art at the time the invention was made to incorporate the teaching of Van der Groen et al with the invention of Ivery et al, since that would increase the integration of the device.

8. Claims 20 and 21 are rejected under 35 U.S.C. 103(a) as being unpatentable over lyer et al. in view of Van der Groen et al. US Patent No. 6,093,577.

lyer et al disclose (see figs. 1-3, pages 8 and 11) a silicon oxide nitride film 106 over a substrate; wherein the silicon oxide nitride film ranges from 0.3 to 1.6 in a ratio of the concentration of nitrogen to the concentration of silicon; wherein the silicon oxide nitride film falls within the claimed range of 0.1 to 1.7 in a ratio of the concentration of oxygen to the concentration of silicon (as in claim 21).

Van der Groen et al disclose (see figs. 1-10 and col. 5, lines 60-65) a film transistor provided in a pixel and over silicon oxide nitride film 13; a first semiconductor film comprising a first channel forming region of said first transistor; a source region and a drain region provided in said first semiconductor film and sandwiching said first channel forming region; a first gate insulating film provided over said first channel

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forming region; a first gate electrode provided adjacent to said first channel forming region and over said first gate insulating film; a pixel electrode 8 provided over a substrate and connected with one of said source region and said drain region; a second transistor provided in a driver and over said silicon oxide nitride film; a second semiconductor film comprising a second channel forming region of said second transistor; a second gate insulating film provided over said second channel forming region; a second gate electrode provided adjacent to said second channel forming region and over said second gate insulating film.

Therefore, it would have been obvious to one skilled in the art at the time the invention was made to incorporate the teaching of Van der Groen et al with the invention of Ivery et al. since that would increase the integration of the device.

As to claims 14-17 and 22-57, the prior art omits that electronic equipment selected from the group consisting of a video camera, a digital camera and other various electronic equipment. However, Examiner takes Official Notice that an electronic equipment comprising a display device wherein said electronic equipment selected from the group consisting of a video camera or a digital camera is conventional and well known. Therefore, it would have been obvious to one skilled in the art at the time the invention was made to have used any of the various electronic equipment since Examiner takes Official Notice that due to their low power consumption, displays have become a necessary and indispensable structural element of an electronic equipment.

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### Response to Arguments

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9. Applicant's arguments filed 11/13/02 have been fully considered but they are not persuasive. The prior art discloses an SOI technology (see page 8, lines 10-20) and designates reference numeral 120 as an active region, which would read on the claimed invention including the limitation semiconductor film recited in the claims.

### Conclusion

10. THIS ACTION IS MADE FINAL. Applicant is reminded of the extension of time policy as set forth in 37 CFR 1.136(a).

A shortened statutory period for reply to this final action is set to expire THREE MONTHS from the mailing date of this action. In the event a first reply is filed within TWO MONTHS of the mailing date of this final action and the advisory action is not mailed until after the end of the THREE-MONTH shortened statutory period, then the shortened statutory period will expire on the date the advisory action is mailed, and any extension fee pursuant to 37 CFR 1.136(a) will be calculated from the mailing date of the advisory action. In no event, however, will the statutory period for reply expire later than SIX MONTHS from the mailing date of this final action.

Any inquiry concerning this communication or earlier communications from the examiner should be directed to A. Sefer whose telephone number is (703) 605-1227.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Nathan J Flynn can be reached on (703) 308-6601.

ANS January 27, 2003

> NATHAN J. FLYNN SUPERVISORY PATENT EXAMINER TECHNOLOGY CENTER 2800